

<b>Notice of References Cited</b>	Application/Control No. 09/773,131	Applicant(s)/Patent Under Reexamination DECRE, MICHEL MARCEL JOS	
	Examiner Wesley D. Markham	Art Unit 1762	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,068,019	01-1978	Boeckl, Richard Stefan	438/780
	B	US-5,294,257	03-1994	Kelly et al.	118/52
	C	US-5,250,116	10-1993	Tanimoto, Keisuke	118/664
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11-86356 A	03-1999	Japan	Takase et al.	-
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.